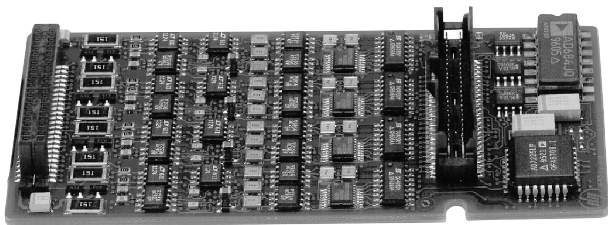


# Agilent E1510A

## 4-Channel Sample and Hold Input SCP

### Data Sheet

- Use with Agilent E1413C/E1415A/E1419A
- Four sample and hold channels
- Four direct input channels
- Samples all channels simultaneously, reduces skew



Agilent E1510A

### Description

The Agilent E1510A 4-Channel Sample and Hold SCP provides four channels of sample and hold inputs, and four channels of direct inputs for the A/Ds. The sample and hold inputs sample all four channels simultaneously to reduce the skew introduced by scanning.

The SCP circuitry provides a voltage gain of 0.5, 8, 64, or 512 for each channel.

The low-pass filter on each sample and hold channel is a 6th order Bessel active RC filter used to provide alias protection and noise reduction. The filter cutoff frequencies are 1 kHz, 500 Hz, 250 Hz, 100 Hz, and 15 Hz.

Use the E1510A with the following VXI modules:

| Model  | Description                                  |
|--------|--|
| E1413C | 64-Channel Scanning A/D Converter            |
| E1415A | Algorithmic Closed Loop Controller           |
| E1419A | Multifunction Measurement and Control Module |

Refer to the Agilent Technologies Website for recent product updates, if applicable.



## Product Specifications

These specifications for the E1510A reflect the combined performance of the scanning A/D and the E1510A SCP.

### Measurement Ranges

**DC Volts:** 0 V to  $\pm 8$  V Full Scale

### Input Characteristics

**Maximum input voltage (normal mode plus common mode):**

**Operating:**  $< \pm 16$  V peak  
**Damage level:**  $> \pm 42$  V peak

**Maximum common mode voltage:**

**Operating:**  $< \pm 16$  V peak  
**Damage level:**  $> \pm 42$  V peak

**Common mode rejection (0 to 60 Hz):**

**x0.5 gain:**  $> 60$  dB  
**x8 gain:**  $> 78$  dB  
**x64 gain:**  $> 100$  dB  
**x512 gain:**  $> 100$  dB

**Input impedance:**  $> 100$  M $\Omega$

### Maximum Tare Cal Offset

*Maximum tare cal offset depends on A/D range and SCP gain.*

| Gain | Maximum Offset           |
|------|--------------------------|
| x0.5 | $\pm 25\%$ of full scale |
| x8   | $\pm 90$ mV              |
| x64  | $\pm 95$ mV              |
| x512 | $\pm 95$ mV              |

### Filter Characteristics (6-pole Bessel filter)

**Normal mode rejection:**

**15 Hz filter:**

**15 Hz:**  $-3$  dB  
**50 Hz:**  $> 33$  dB  
**60 Hz:**  $> 43$  dB

**100 Hz filter:**

**100 Hz:**  $-3$  dB  
**400 Hz:**  $> 43$  dB

**250 Hz filter:**

**250 Hz:**  $-3$  dB  
**1000 Hz:**  $> 43$  dB

**500 Hz filter:**

**500 Hz:**  $-3$  dB  
**2000 Hz:**  $> 43$  dB

**1000 Hz filter:**

**1000 Hz:**  $-3$  dB  
**4000 Hz:**  $> 43$  dB

### Sample Time Skew Between Channels

Because the low-pass filter precedes the sample and hold, the interchannel sample time skew is primarily determined by the matching of the filter propagation delay times. The table below lists the propagation delay for a step function input (measured at 50% of the final value) for each filter setting, as well as the matching between channels programmed to the same filter setting.

| Bandwidth | Step propagation delay (nominal) | Delay matching ( $\pm$ from nominal) |
|-----------|----------------------------------|--------------------------------------|
| 1 kHz:    | 427.5 $\mu$ sec                  | 10 $\mu$ sec                         |
| 500 Hz:   | 854.9 $\mu$ sec                  | 20 $\mu$ sec                         |
| 250 Hz:   | 1.710 msec                       | 40 $\mu$ sec                         |
| 100 Hz:   | 4.275 msec                       | 100 $\mu$ sec                        |
| 15 Hz:    | 28.50 msec                       | 670 $\mu$ sec                        |

### Maximum Filter Overshoot

$< 1\%$  of input step size.

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### Measurement Accuracy DC Voltage

For autorange, add .05% of reading for input voltages  $>\pm 4$  V.

#### Accuracy — Gain x0.5

| Range $\pm$ FS | Linearity % of Reading: | Offset Error: | Noise 3 $\sigma$ : |
|----------------|-------------------------|---------------|--------------------|
| 125 mV:        | 0.02                    | 488 $\mu$ V   | 1.5 $\mu$ V        |
| 0.5 V:         | 0.02                    | 488 $\mu$ V   | 1.5 $\mu$ V        |
| 2.0 V:         | 0.02                    | 488 $\mu$ V   | 1.5 $\mu$ V        |
| 8.0 V:         | 0.02                    | 488 $\mu$ V   | 1.5 $\mu$ V        |

**Temperature Coefficients:** *add tempco error to above table*

**Gain:** 10 ppm/ $^{\circ}$ C (after \*CAL)

**Offset:**

0-30  $^{\circ}$ C: 0  $\mu$ V/ $^{\circ}$ C

30-55  $^{\circ}$ C: 0.75  $\mu$ V/ $^{\circ}$ C

#### Accuracy — Gain x8

| Range $\pm$ FS | Linearity % of Reading: | Offset Error: | Noise 3 $\sigma$ : |
|----------------|-------------------------|---------------|--------------------|
| 7.8 mV:        | 0.02                    | 30.5 $\mu$ V  | 95 $\mu$ V         |
| 31.25 m V:     | 0.02                    | 30.5 $\mu$ V  | 95 $\mu$ V         |
| 125 mV:        | 0.02                    | 30.5 $\mu$ V  | 95 $\mu$ V         |
| 0.5 V:         | 0.02                    | 30.5 $\mu$ V  | 95 $\mu$ V         |

**Temperature Coefficients:** *add tempco error to above table*

**Gain:** 10 ppm/ $^{\circ}$ C (after \*CAL)

**Offset:**

0-30  $^{\circ}$ C: 0  $\mu$ V/ $^{\circ}$ C

30-55  $^{\circ}$ C: 0.75  $\mu$ V/ $^{\circ}$ C

#### Accuracy — Gain x64

| Range $\pm$ FS | Linearity % of Reading: | Offset Error: | Noise 3 $\sigma$ : |
|----------------|-------------------------|---------------|--------------------|
| 3.9 mV:        | 0.02                    | 15 $\mu$ V    | 12 $\mu$ V         |
| 15.6 m V:      | 0.02                    | 15 $\mu$ V    | 12 $\mu$ V         |
| 62.5 mV:       | 0.02                    | 15 $\mu$ V    | 12 $\mu$ V         |

**Temperature Coefficients:** *add tempco error to above table*

**Gain:** 10 ppm/ $^{\circ}$ C (after \*CAL)

**Offset:**

0-40  $^{\circ}$ C: 0.14  $\mu$ V/ $^{\circ}$ C

40-55  $^{\circ}$ C: 0.38  $\mu$ V/ $^{\circ}$ C

#### Accuracy — Gain x512

| Range $\pm$ FS | Linearity % of Reading: | Offset Error: | Noise 3 $\sigma$ : |
|----------------|-------------------------|---------------|--------------------|
| 7.81 mV:       | 0.04                    | 15 $\mu$ V    | 2 $\mu$ V          |

**Temperature Coefficients:** *add tempco error to above table*

**Gain:** 10 ppm/ $^{\circ}$ C (after \*CAL)

**Offset:**

0-40  $^{\circ}$ C: 0.14  $\mu$ V/ $^{\circ}$ C

40-55  $^{\circ}$ C: 0.38  $\mu$ V/ $^{\circ}$ C

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### Current Requirements (Amps)

| 5 V max | 24 V max | -24 V max |
|---------|----------|-----------|
| 0.01    | 0.125    | 0.125     |

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### Ordering Information

| Description                       | Product No. |
|-----------------------------------|-------------|
| 4-Channel Sample & Hold Input SCP | E1510A      |

## Related Literature

*2000 Test System and VXI Catalog CD-ROM*,  
Agilent Pub. No. 5980-0308E (detailed specifications for VXI products)

*2000 Test System and VXI Catalog*,  
Agilent Pub. No. 5980-0307E (overview of VXI products )

*1998 Test System and VXI Products Data Book*,  
Agilent Pub. No. 5966-2812E

## Online

Internet access for Agilent product information, services and support  
[www.agilent.com/find/tmdir](http://www.agilent.com/find/tmdir)

VXI product information  
[www.agilent.com/find/vxi](http://www.agilent.com/find/vxi)

Defense Electronics Applications  
[www.agilent.com/find/defense\\_ATE](http://www.agilent.com/find/defense_ATE)

Agilent Technologies VXI Channel Partners  
[www.agilent.com/find/vxichanpart](http://www.agilent.com/find/vxichanpart)

Agilent Technologies' HP VEE Application Website  
[www.agilent.com/find/vee](http://www.agilent.com/find/vee)

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